

最终数据表

英飞凌CoolSiC™ 1200 V SiC MOSFET G2：碳化硅 MOSFET

特性

- $T_{vj} = 25^{\circ}\text{C}$  时  $V_{DSS} = 1200\text{ V}$
- $T_C = 100^{\circ}\text{C}$  时  $I_{DDC} = 36\text{ A}$
- $R_{DS(on)} = 39.6\text{ m}\Omega$  ( $V_{GS} = 18\text{ V}$ 、 $T_{vj} = 25^{\circ}\text{C}$  时)
- 开关损耗非常低
- 过载运行最高结温可达  $T_{vj} = 200^{\circ}\text{C}$
- 短路耐受时间  $2\text{ }\mu\text{s}$
- 基准栅极阈值电压,  $V_{GS(th)} = 4.2\text{ V}$
- 具有抗寄生导通能力, 可应用  $0\text{ V}$  关断栅极电压
- 坚固的体二极管, 适用于硬换向
- .XT 互连技术, 实现业界领先的热性能
- 合适的英飞凌栅极驱动器可在 <https://www.infineon.com/gdfinder> 找到

潜在的应用

- 电动汽车充电桩
- 在线式UPS/工业UPS
- 组串式逆变器
- 通用驱动器 (GPD)

产品认证

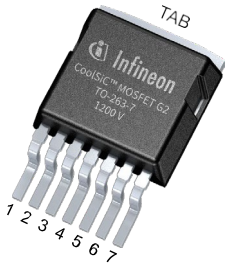
- 符合JEDEC47/20/22相关测试的工业应用要求

描述

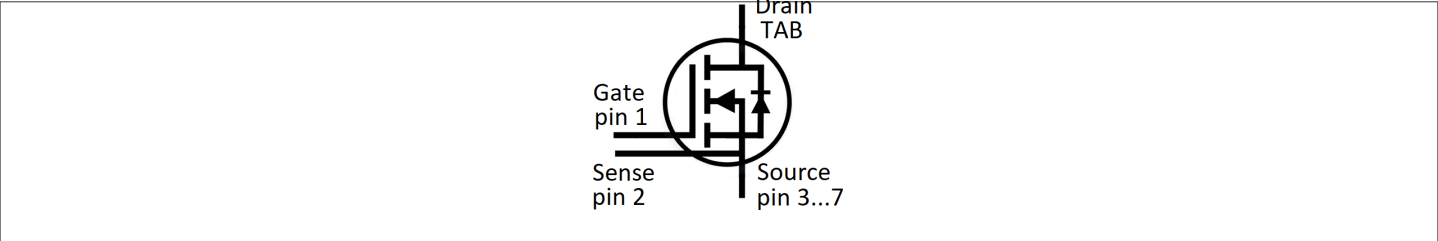
引脚定义:

- 引脚 1 - 栅极
- 引脚 2 - 开尔文传感触点
- 引脚 3...7 - 源极
- Tab - 漏极

注意: 源极和开尔文传感触点引脚不可互换, 互换可能会导致故障 (仅适用于 4 pin及TO263-7L封装)



- Halogen-free
- Green
- Lead-free
- RoHS



| Type           | Package        | Marking  |
|----------------|----------------|----------|
| IMBG120R040M2H | PG-TO263-7-U01 | 12M2H040 |



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1封装

## 1 封装

表1 特征值

| Parameter                                           | Symbol        | Note or test condition                               | Values |      |      | Unit |
|-----------------------------------------------------|---------------|------------------------------------------------------|--------|------|------|------|
|                                                     |               |                                                      | Min.   | Typ. | Max. |      |
| Storage temperature                                 | $T_{stg}$     |                                                      | -55    |      | 150  | °C   |
| Soldering temperature                               | $T_{sold}$    | reflow soldering (MSL1 according to JEDEC J-STD-020) |        |      | 260  | °C   |
| Thermal resistance, junction-ambient                | $R_{th(j-a)}$ |                                                      |        |      | 62   | K/W  |
| MOSFET/body diode thermal resistance, junction-case | $R_{th(j-c)}$ |                                                      |        | 0.46 | 0.6  | K/W  |

## 2 MOSFET

表2 最大额定值

| Parameter                                                                    | Symbol    | Note or test condition                                                                                                   |                       | Values   | Unit          |
|------------------------------------------------------------------------------|-----------|--------------------------------------------------------------------------------------------------------------------------|-----------------------|----------|---------------|
| Drain-source voltage                                                         | $V_{DSS}$ | $T_{vj} \geq 25\text{ °C}$                                                                                               |                       | 1200     | V             |
| Continuous DC drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$ | $I_{DDC}$ | $V_{GS} = 18\text{ V}$                                                                                                   | $T_c = 25\text{ °C}$  | 52       | A             |
|                                                                              |           |                                                                                                                          | $T_c = 100\text{ °C}$ | 36       |               |
| Peak drain current, $t_p$ limited by $T_{vj(max)}$ <sup>1)</sup>             | $I_{DM}$  | $V_{GS} = 18\text{ V}$                                                                                                   |                       | 108      | A             |
| Gate-source voltage, max. transient voltage                                  | $V_{GS}$  | $t_p \leq 0.5\text{ }\mu\text{s}$ , $D < 0.01$                                                                           |                       | -10...25 | V             |
| Gate-source voltage, max. static voltage <sup>2)</sup>                       | $V_{GS}$  |                                                                                                                          |                       | -7...23  | V             |
| Avalanche energy, single pulse                                               | $E_{AS}$  | $I_D = 17.5\text{ A}$ , $V_{DD} = 50\text{ V}$ , $L = 1.4\text{ mH}$                                                     |                       | 220      | mJ            |
| Avalanche energy, repetitive                                                 | $E_{AR}$  | $I_D = 17.5\text{ A}$ , $V_{DD} = 50\text{ V}$ , $L = 7.2\text{ }\mu\text{H}$                                            |                       | 1.1      | mJ            |
| Short-circuit withstand time                                                 | $t_{SC}$  | $V_{DD} \leq 800\text{ V}$ , $V_{DS,peak} < 1200\text{ V}$ , $V_{GS(on)} = 15\text{ V}$ , $T_{vj(start)} = 25\text{ °C}$ |                       | 2        | $\mu\text{s}$ |
| Power dissipation, limited by $T_{vj(max)}$                                  | $P_{tot}$ |                                                                                                                          | $T_c = 25\text{ °C}$  | 250      | W             |
|                                                                              |           |                                                                                                                          | $T_c = 100\text{ °C}$ | 125      |               |

1) 已通过设计验证。

2) 应用设计中的最大栅源电压应符合IPC-9592B的规定。

**表 3**                      **建议值**

| Parameter                         | Symbol        | Note or test condition | Values  | Unit |
|-----------------------------------|---------------|------------------------|---------|------|
| Recommended turn-on gate voltage  | $V_{GS(on)}$  |                        | 15...18 | V    |
| Recommended turn-off gate voltage | $V_{GS(off)}$ |                        | -5...0  | V    |

**表4**                      **特征值**

| Parameter                                    | Symbol       | Note or test condition                                                                                                          | Values                                               |       |      | Unit |
|----------------------------------------------|--------------|---------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------|-------|------|------|
|                                              |              |                                                                                                                                 | Min.                                                 | Typ.  | Max. |      |
| Drain-source on-state resistance             | $R_{DS(on)}$ | $I_D = 17.5 \text{ A}$                                                                                                          | $T_{vj} = 25 \text{ °C}, V_{GS(on)} = 18 \text{ V}$  | 39.6  |      | mΩ   |
|                                              |              |                                                                                                                                 | $T_{vj} = 150 \text{ °C}, V_{GS(on)} = 18 \text{ V}$ | 81    | 105  |      |
|                                              |              |                                                                                                                                 | $T_{vj} = 175 \text{ °C}, V_{GS(on)} = 18 \text{ V}$ | 94    |      |      |
|                                              |              |                                                                                                                                 | $T_{vj} = 25 \text{ °C}, V_{GS(on)} = 15 \text{ V}$  | 49.4  |      |      |
| Gate-source threshold voltage                | $V_{GS(th)}$ | $I_D = 5.5 \text{ mA}, V_{DS} = V_{GS}$<br>(tested after 1 ms pulse at $V_{GS} = 20 \text{ V}$ )                                | $T_{vj} = 25 \text{ °C}$                             | 3.5   | 4.2  | V    |
|                                              |              |                                                                                                                                 | $T_{vj} = 175 \text{ °C}$                            |       | 3.2  |      |
| Zero gate-voltage drain current              | $I_{DSS}$    | $V_{DS} = 1200 \text{ V}, V_{GS} = 0 \text{ V}$                                                                                 | $T_{vj} = 25 \text{ °C}$                             |       | 150  | μA   |
|                                              |              |                                                                                                                                 | $T_{vj} = 175 \text{ °C}$                            | 2.6   |      |      |
| Gate leakage current                         | $I_{GSS}$    | $V_{DS} = 0 \text{ V}$                                                                                                          | $V_{GS} = 23 \text{ V}$                              |       | 120  | nA   |
|                                              |              |                                                                                                                                 | $V_{GS} = -10 \text{ V}$                             |       | -120 |      |
| Forward transconductance                     | $g_{fs}$     | $I_D = 17.5 \text{ A}, V_{DS} = 20 \text{ V}$                                                                                   |                                                      | 11.8  |      | S    |
| Internal gate resistance                     | $R_{G,int}$  | $f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$                                                                                     |                                                      | 6.5   |      | Ω    |
| Input capacitance                            | $C_{iss}$    | $V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}, f = 100 \text{ kHz}, V_{AC} = 25 \text{ mV}$                                     |                                                      | 1310  |      | pF   |
| Output capacitance                           | $C_{oss}$    | $V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}, f = 100 \text{ kHz}, V_{AC} = 25 \text{ mV}$                                     |                                                      | 55    |      | pF   |
| Reverse transfer capacitance                 | $C_{rss}$    | $V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}, f = 100 \text{ kHz}, V_{AC} = 25 \text{ mV}$                                     |                                                      | 4.7   |      | pF   |
| $C_{oss}$ stored energy                      | $E_{oss}$    | $V_{DS} = 0...800 \text{ V}, V_{GS} = 0 \text{ V}, f = 100 \text{ kHz}, V_{AC} = 25 \text{ mV}$ , Calculated based on $C_{oss}$ |                                                      | 23    |      | μJ   |
| Output charge                                | $Q_{oss}$    | $V_{DS} = 0...800 \text{ V}, V_{GS} = 0 \text{ V}$ , Calculated based on $C_{oss}$                                              |                                                      | 85.2  |      | nC   |
| Effective output capacitance, energy related | $C_{o(er)}$  | $V_{DS} = 0...800 \text{ V}, V_{GS} = 0 \text{ V}$                                                                              |                                                      | 71.9  |      | pF   |
| Effective output capacitance, time related   | $C_{o(tr)}$  | $I_D = \text{constant}, V_{DS} = 0...800 \text{ V}, V_{GS} = 0 \text{ V}$                                                       |                                                      | 106.5 |      | pF   |

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表 4 (续) 特征值

| Parameter            | Symbol       | Note or test condition                                                                                                                                                                                                     | Values                               |      |      | Unit          |
|----------------------|--------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------|------|------|---------------|
|                      |              |                                                                                                                                                                                                                            | Min.                                 | Typ. | Max. |               |
| Total gate charge    | $Q_G$        | $V_{DD} = 800\text{ V}$ , $I_D = 17.5\text{ A}$ , $V_{GS} = -2/18\text{ V}$ , turn-on pulse                                                                                                                                |                                      | 39   |      | nC            |
| Plateau gate charge  | $Q_{GS(pl)}$ | $V_{DD} = 800\text{ V}$ , $I_D = 17.5\text{ A}$ , $V_{GS} = -2/18\text{ V}$ , turn-on pulse                                                                                                                                |                                      | 8.5  |      | nC            |
| Gate-to-drain charge | $Q_{GD}$     | $V_{DD} = 800\text{ V}$ , $I_D = 17.5\text{ A}$ , $V_{GS} = -2/18\text{ V}$ , turn-on pulse                                                                                                                                |                                      | 10.4 |      | nC            |
| Turn-on delay time   | $t_{d(on)}$  | $V_{DD} = 800\text{ V}$ , $I_D = 17.5\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 15\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 3    |      | ns            |
|                      |              |                                                                                                                                                                                                                            | $T_{vj} = 175\text{ }^\circ\text{C}$ | 3.2  |      |               |
| Rise time            | $t_r$        | $V_{DD} = 800\text{ V}$ , $I_D = 17.5\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 15\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 14.7 |      | ns            |
|                      |              |                                                                                                                                                                                                                            | $T_{vj} = 175\text{ }^\circ\text{C}$ | 14.5 |      |               |
| Turn-off delay time  | $t_{d(off)}$ | $V_{DD} = 800\text{ V}$ , $I_D = 17.5\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 15\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 6.4  |      | ns            |
|                      |              |                                                                                                                                                                                                                            | $T_{vj} = 175\text{ }^\circ\text{C}$ | 11.1 |      |               |
| Fall time            | $t_f$        | $V_{DD} = 800\text{ V}$ , $I_D = 17.5\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 15\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 4    |      | ns            |
|                      |              |                                                                                                                                                                                                                            | $T_{vj} = 175\text{ }^\circ\text{C}$ | 4.7  |      |               |
| Turn-on energy       | $E_{on}$     | $V_{DD} = 800\text{ V}$ , $I_D = 17.5\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 15\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 113  |      | $\mu\text{J}$ |
|                      |              |                                                                                                                                                                                                                            | $T_{vj} = 175\text{ }^\circ\text{C}$ | 222  |      |               |
| Turn-off energy      | $E_{off}$    | $V_{DD} = 800\text{ V}$ , $I_D = 17.5\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 15\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 24   |      | $\mu\text{J}$ |
|                      |              |                                                                                                                                                                                                                            | $T_{vj} = 175\text{ }^\circ\text{C}$ | 35   |      |               |

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表 4 (续) 特征值

| Parameter                            | Symbol                | Note or test condition                                                                                                                                                                                                                                                         |                                                                                                 | Values |            |      | Unit               |
|--------------------------------------|-----------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------|--------|------------|------|--------------------|
|                                      |                       |                                                                                                                                                                                                                                                                                |                                                                                                 | Min.   | Typ.       | Max. |                    |
| Total switching energy <sup>1)</sup> | $E_{\text{tot}}$      | $V_{\text{DD}} = 800 \text{ V}$ , $I_{\text{D}} = 17.5 \text{ A}$ ,<br>$V_{\text{GS}} = 0/18 \text{ V}$ ,<br>$R_{\text{GS(on)}} = 2.3 \Omega$ ,<br>$R_{\text{GS(off)}} = 2.3 \Omega$ ,<br>$L_{\sigma} = 15 \text{ nH}$ , diode: body<br>diode at $V_{\text{GS}} = 0 \text{ V}$ | $T_{\text{vj}} = 25 \text{ }^{\circ}\text{C}$<br>$T_{\text{vj}} = 175 \text{ }^{\circ}\text{C}$ |        | 187<br>397 |      | $\mu\text{J}$      |
| Virtual junction temperature         | $T_{\text{vj}}$       |                                                                                                                                                                                                                                                                                |                                                                                                 | -55    |            | 175  | $^{\circ}\text{C}$ |
| Virtual junction temperature         | $T_{\text{vj(over)}}$ | overload, cumulative max. 100 h <sup>2)</sup>                                                                                                                                                                                                                                  |                                                                                                 |        |            | 200  | $^{\circ}\text{C}$ |

1) 包括  $E_{\text{fr}}$

2) 最多 5000 次循环。最大  $\Delta T$  限制为 100 K。

注：芯片技术的特征是高达 200 kV/ $\mu\text{s}$ 。测量的  $dV/dt$  受到测量测试设置和封装的限制。

除非另有规定，特性均为  $T_{\text{vj}} = 25^{\circ}\text{C}$ 。

### 3 体二极管 (MOSFET)

表5 最大额定值

| Parameter                                                                     | Symbol           | Note or test condition                           | Values | Unit |
|-------------------------------------------------------------------------------|------------------|--------------------------------------------------|--------|------|
| Drain-source voltage                                                          | $V_{\text{DSS}}$ | $T_{\text{vj}} \geq 25 \text{ }^{\circ}\text{C}$ | 1200   | V    |
| Peak reverse drain current,<br>$t_{\text{p}}$ limited by $T_{\text{vj(max)}}$ | $I_{\text{SM}}$  | $V_{\text{GS}} = 0 \text{ V}$                    | 45     | A    |

表6 特征值

| Parameter                            | Symbol           | Note or test condition                                                                                                                                                                                         |                                                | Values |      |      | Unit          |
|--------------------------------------|------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------|--------|------|------|---------------|
|                                      |                  |                                                                                                                                                                                                                |                                                | Min.   | Typ. | Max. |               |
| Drain-source reverse voltage         | $V_{\text{SD}}$  | $I_{\text{SD}} = 17.5 \text{ A}$ , $V_{\text{GS}} = 0 \text{ V}$                                                                                                                                               | $T_{\text{vj}} = 25 \text{ }^{\circ}\text{C}$  |        | 4.2  | 5.5  | V             |
|                                      |                  |                                                                                                                                                                                                                | $T_{\text{vj}} = 100 \text{ }^{\circ}\text{C}$ |        | 4.11 |      |               |
|                                      |                  |                                                                                                                                                                                                                | $T_{\text{vj}} = 175 \text{ }^{\circ}\text{C}$ |        | 4.05 |      |               |
| MOSFET forward recovery charge       | $Q_{\text{fr}}$  | $V_{\text{DD}} = 800 \text{ V}$ ,<br>$I_{\text{SD}} = 17.5 \text{ A}$ , $V_{\text{GS}} = 0 \text{ V}$ ,<br>$-di_{\text{SD}}/dt = 1000 \text{ A}/\mu\text{s}$ , $Q_{\text{fr}}$<br>includes also $Q_{\text{C}}$ | $T_{\text{vj}} = 25 \text{ }^{\circ}\text{C}$  |        | 0.21 |      | $\mu\text{C}$ |
|                                      |                  |                                                                                                                                                                                                                | $T_{\text{vj}} = 175 \text{ }^{\circ}\text{C}$ |        | 0.36 |      |               |
| MOSFET peak forward recovery current | $I_{\text{frm}}$ | $V_{\text{DD}} = 800 \text{ V}$ ,<br>$I_{\text{SD}} = 17.5 \text{ A}$ , $V_{\text{GS}} = 0 \text{ V}$ ,<br>$-di_{\text{SD}}/dt = 1000 \text{ A}/\mu\text{s}$ , $Q_{\text{fr}}$<br>includes also $Q_{\text{C}}$ | $T_{\text{vj}} = 25 \text{ }^{\circ}\text{C}$  |        | 6.4  |      | A             |
|                                      |                  |                                                                                                                                                                                                                | $T_{\text{vj}} = 175 \text{ }^{\circ}\text{C}$ |        | 8.4  |      |               |

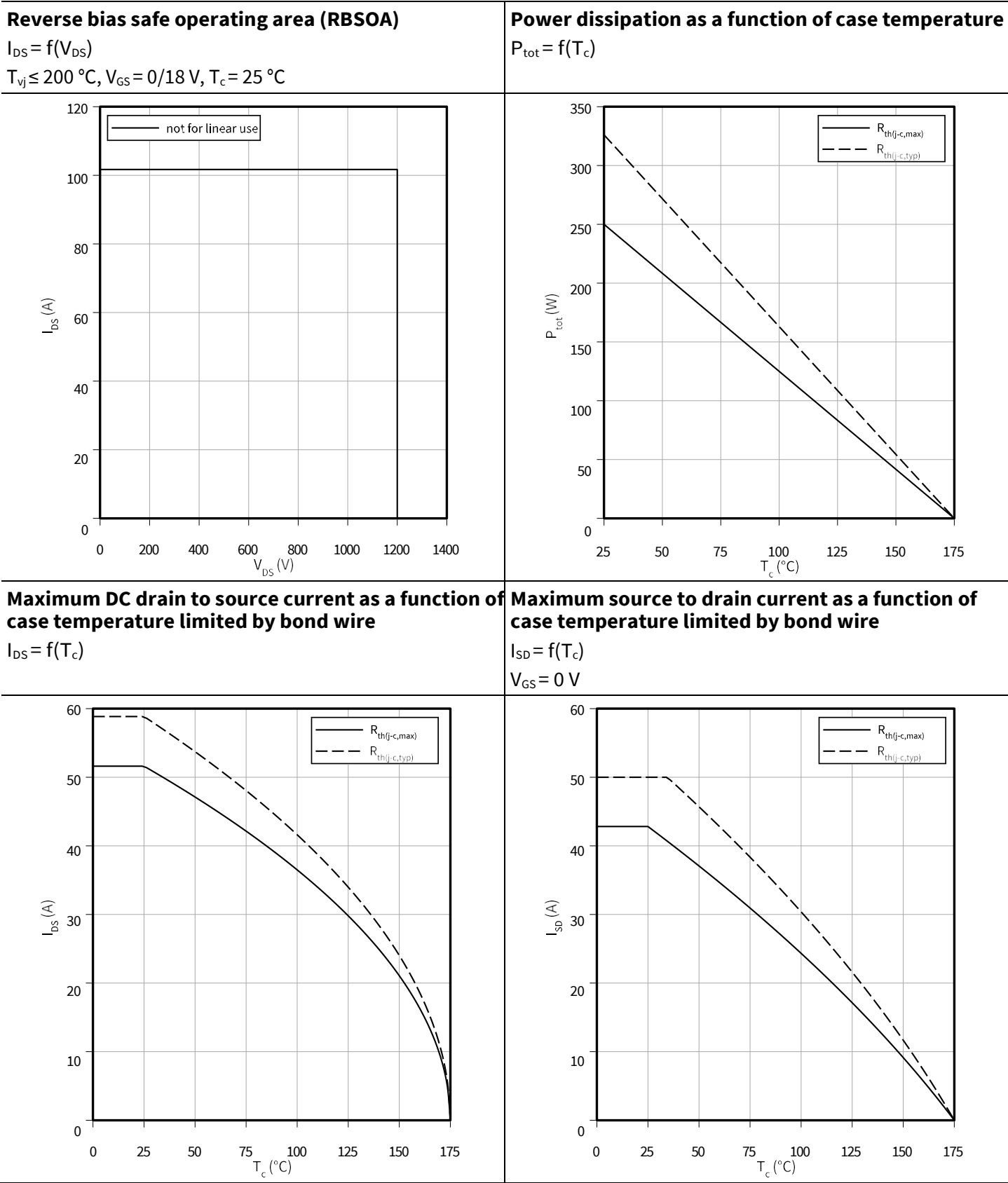
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表 6（续）特征值

| Parameter                      | Symbol         | Note or test condition                                                                                                                                         |                          | Values |      |      | Unit               |
|--------------------------------|----------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------|--------|------|------|--------------------|
|                                |                |                                                                                                                                                                |                          | Min.   | Typ. | Max. |                    |
| MOSFET forward recovery energy | $E_{fr}$       | $V_{DD} = 800\text{ V}$ ,<br>$I_{SD} = 17.5\text{ A}$ , $V_{GS} = 0\text{ V}$ ,<br>$-di_{SD}/dt = 1000\text{ A}/\mu\text{s}$ , $Q_{fr}$<br>includes also $Q_C$ | $T_{vj} = 25\text{ °C}$  |        | 50   |      | $\mu\text{J}$      |
|                                |                |                                                                                                                                                                | $T_{vj} = 175\text{ °C}$ |        | 140  |      |                    |
| Virtual junction temperature   | $T_{vj}$       |                                                                                                                                                                |                          | -55    |      | 175  | $^{\circ}\text{C}$ |
| Virtual junction temperature   | $T_{vj(over)}$ | overload, cumulative max. 100 h <sup>1)</sup>                                                                                                                  |                          |        |      | 200  | $^{\circ}\text{C}$ |

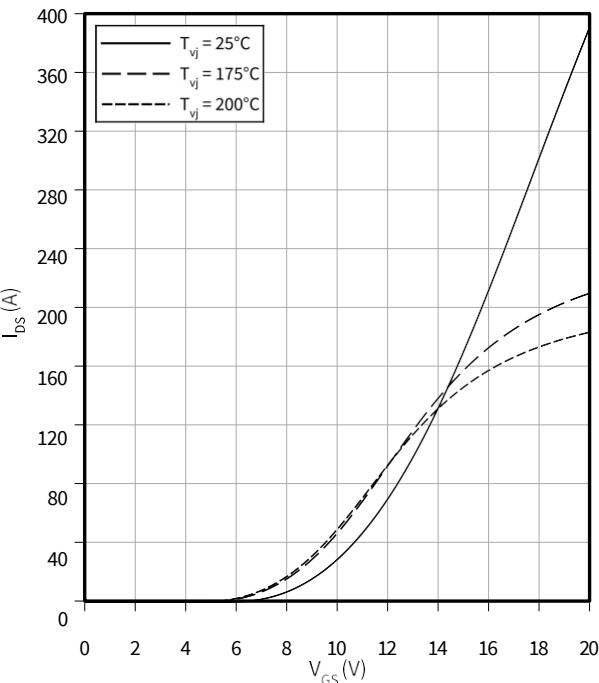
1) 最多 5000 次循环。最大Δ T 限制为 100 K。

4 特性图



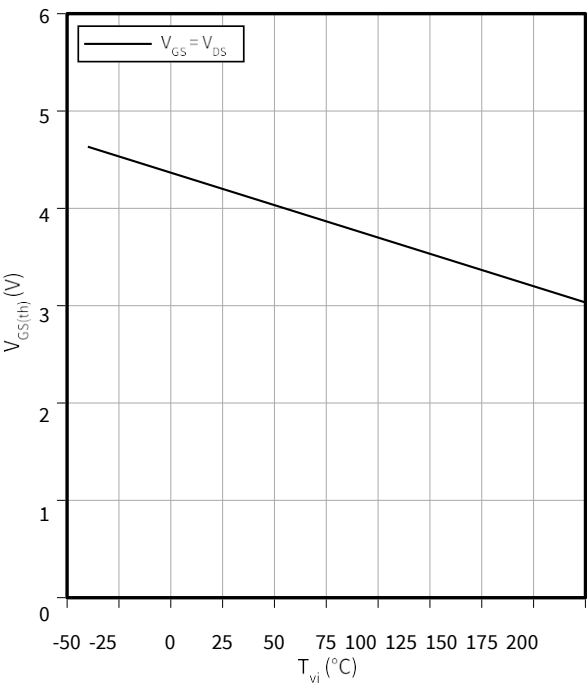
Typical transfer characteristic

$I_{DS} = f(V_{GS})$   
 $V_{DS} = 20\text{ V}$ ,  $t_p = 20\text{ }\mu\text{s}$



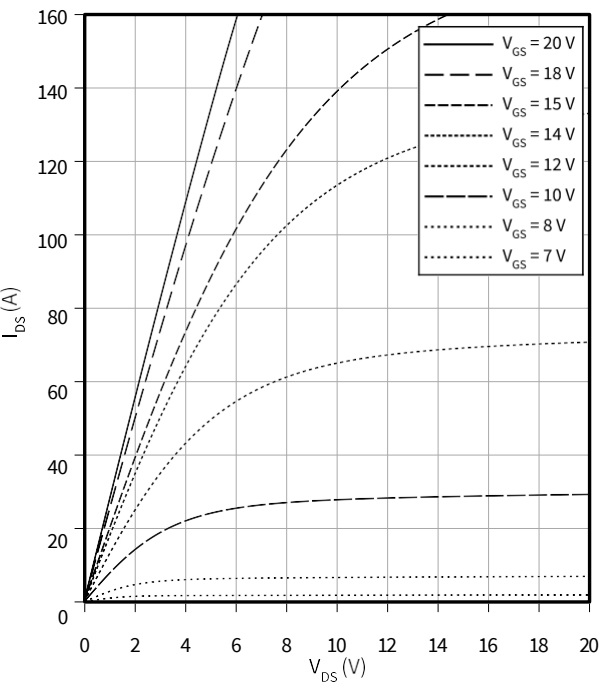
Typical gate-source threshold voltage as a function of junction temperature

$V_{GS(th)} = f(T_{vj})$   
 $I_D = 5.5\text{ mA}$



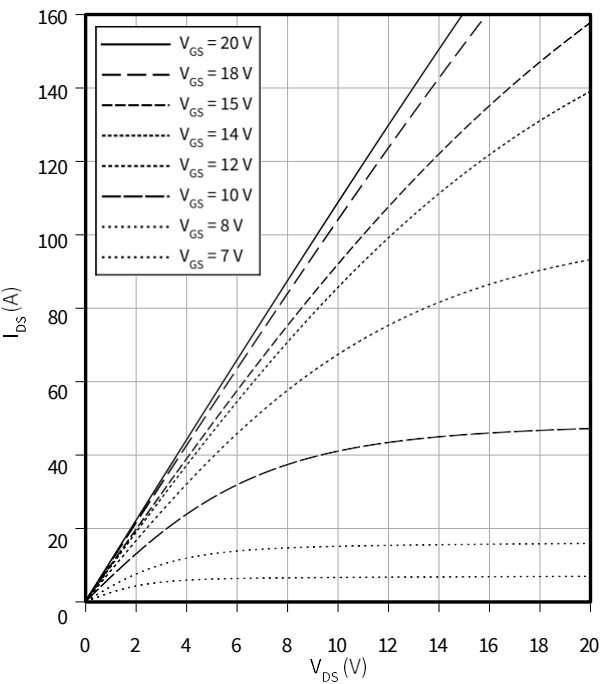
Typical output characteristic,  $V_{GS}$  as parameter

$I_{DS} = f(V_{DS})$   
 $T_{vj} = 25\text{ }^\circ\text{C}$ ,  $t_p = 20\text{ }\mu\text{s}$



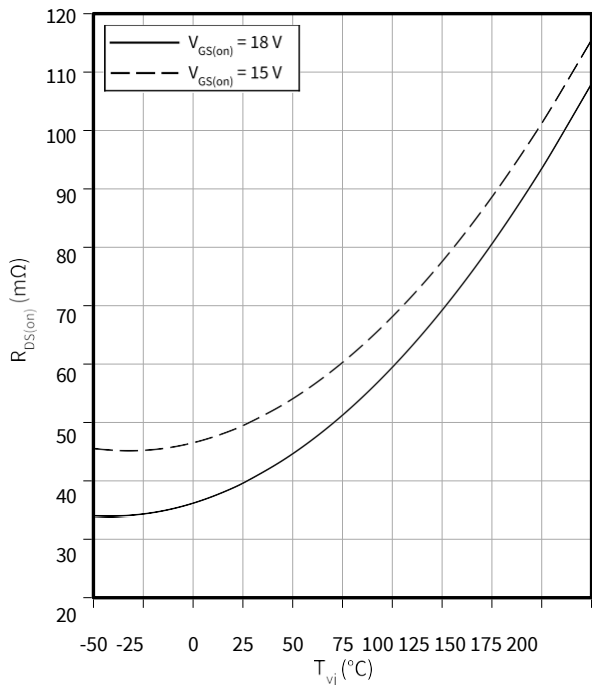
Typical output characteristic,  $V_{GS}$  as parameter

$I_{DS} = f(V_{DS})$   
 $T_{vj} = 175\text{ }^\circ\text{C}$ ,  $t_p = 20\text{ }\mu\text{s}$



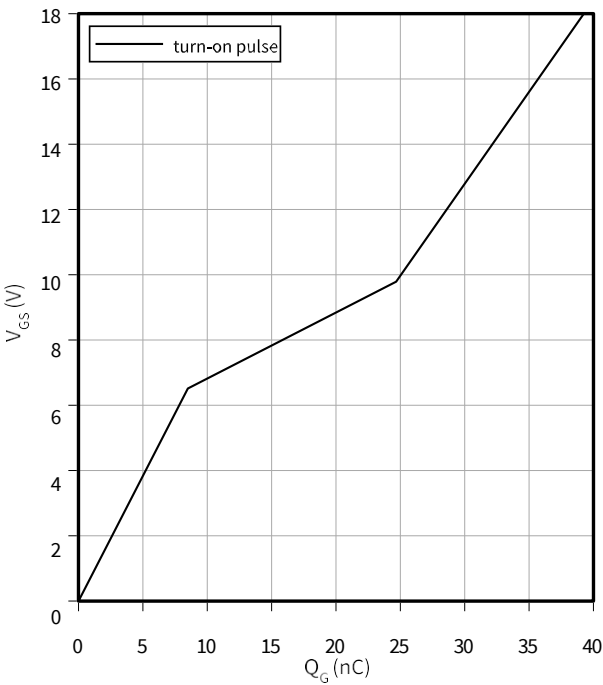
Typical on-state resistance as a function of junction temperature

$R_{DS(on)} = f(T_{vj})$   
 $I_D = 17.5\text{ A}$



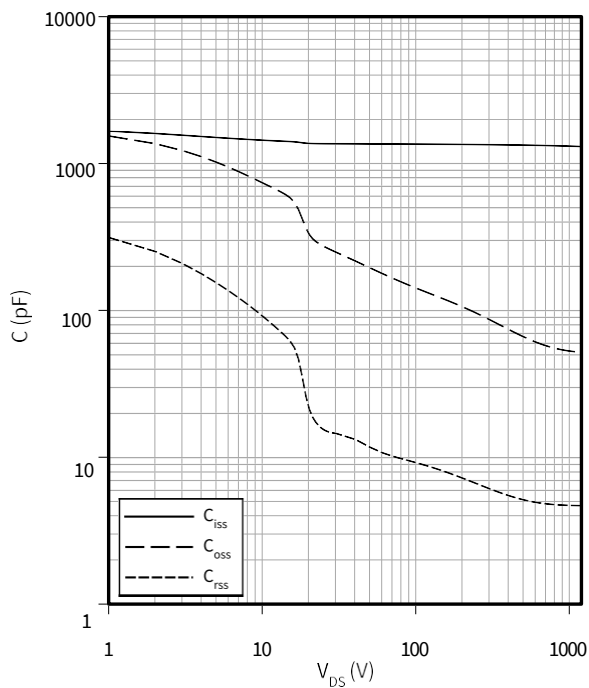
Typical gate charge

$V_{GS} = f(Q_G)$   
 $I_D = 17.5\text{ A}, V_{DS} = 800\text{ V}$



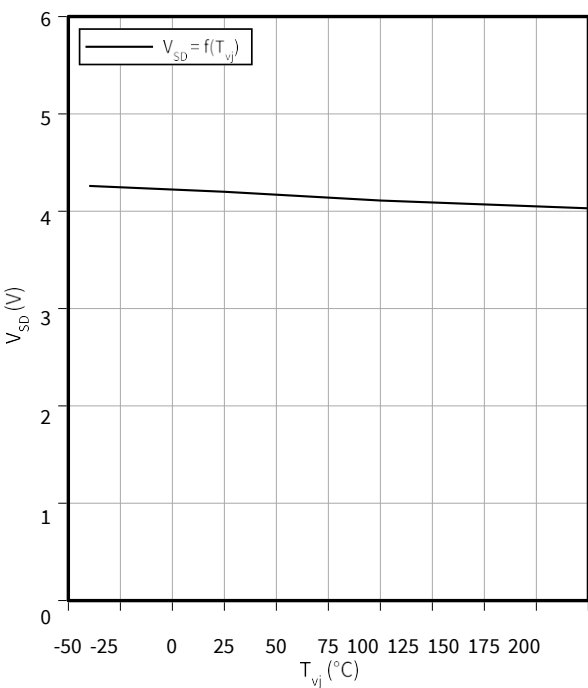
Typical capacitance as a function of drain-source voltage

$C = f(V_{DS})$   
 $f = 100\text{ kHz}, V_{GS} = 0\text{ V}$



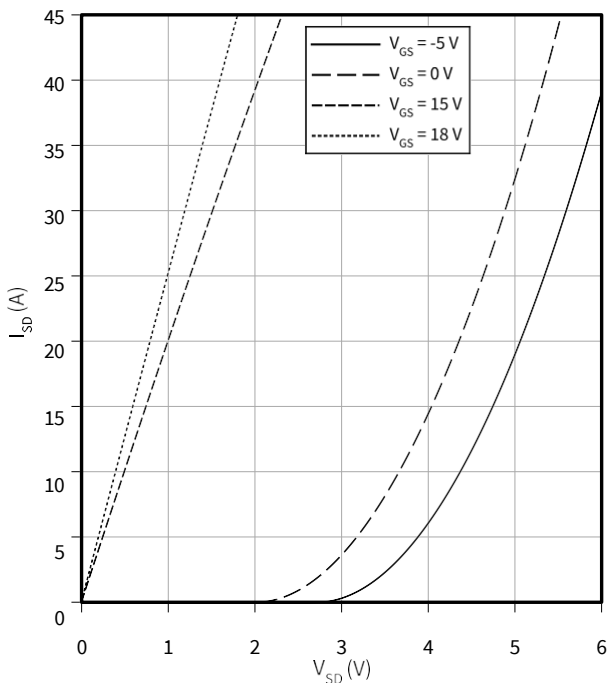
Typical reverse drain voltage as function of junction temperature

$V_{SD} = f(T_{vj})$   
 $I_{SD} = 17.5\text{ A}, V_{GS} = 0\text{ V}$



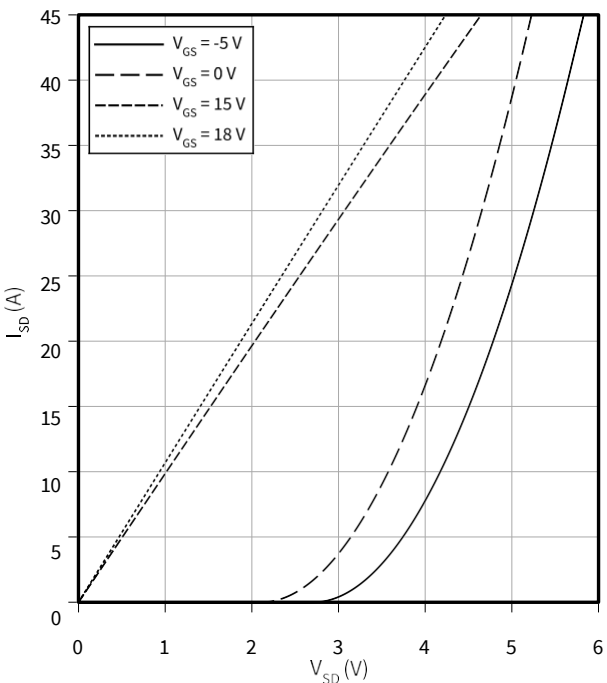
Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 25\text{ °C}$ ,  $t_p = 20\text{ }\mu\text{s}$



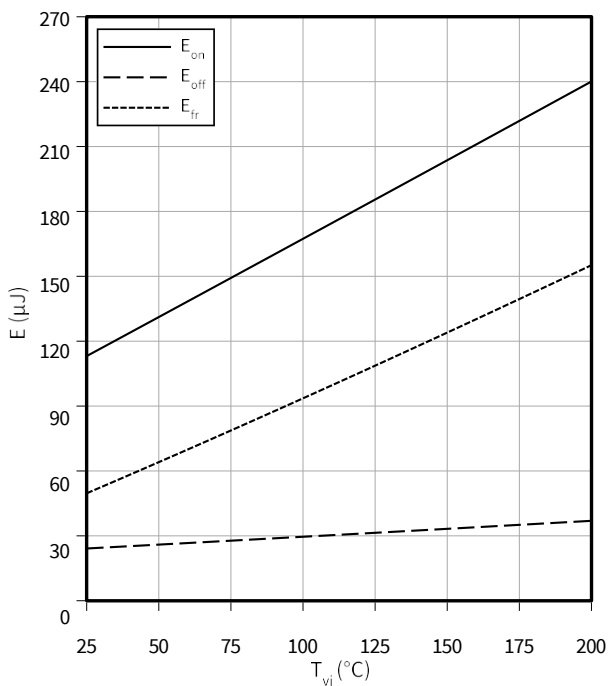
Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 175\text{ °C}$ ,  $t_p = 20\text{ }\mu\text{s}$



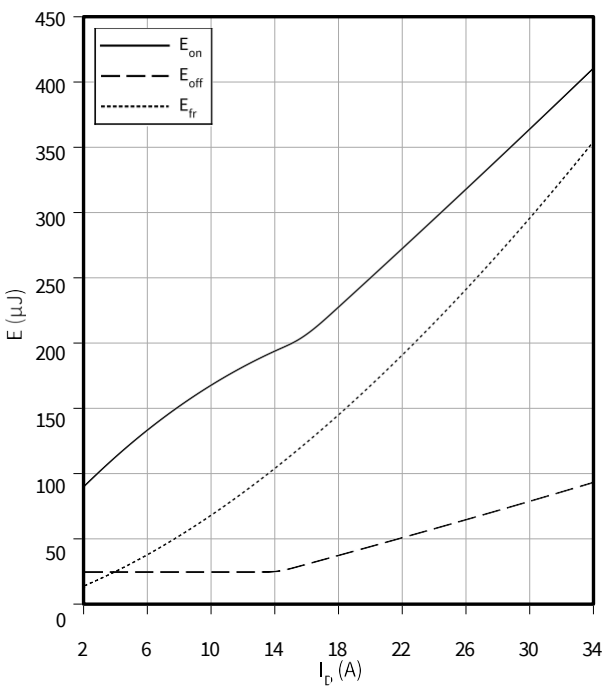
Typical switching energy as a function of junction temperature, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$

$E = f(T_{vj})$   
 $V_{GS} = 0/18\text{ V}$ ,  $I_D = 17.5\text{ A}$ ,  $R_{G,ext} = 2.3\text{ }\Omega$ ,  $V_{DD} = 800\text{ V}$



Typical switching energy as a function of drain current, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$

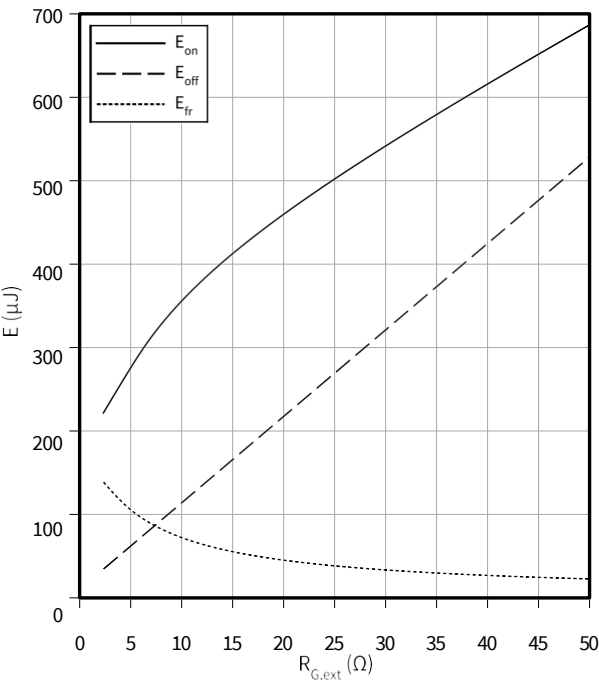
$E = f(I_D)$   
 $V_{GS} = 0/18\text{ V}$ ,  $T_{vj} = 175\text{ °C}$ ,  $R_{G,ext} = 2.3\text{ }\Omega$ ,  $V_{DD} = 800\text{ V}$



Typical switching energy as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$

$E = f(R_{G,ext})$

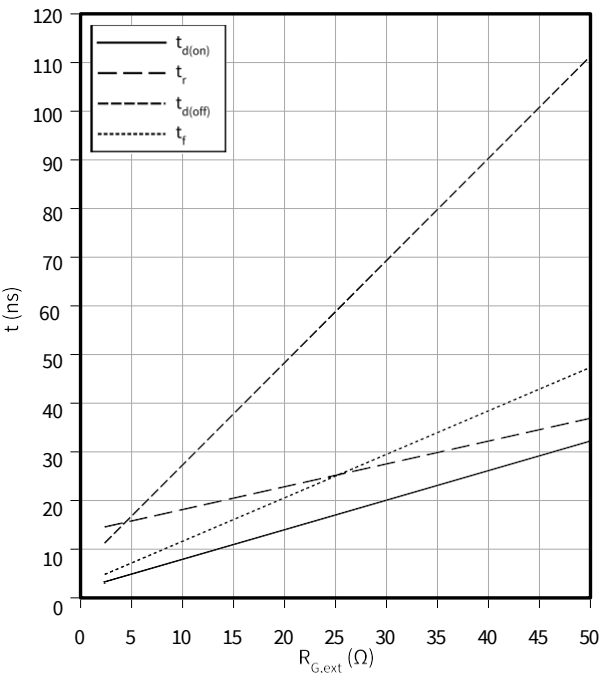
$V_{GS} = 0/18\text{ V}$ ,  $I_D = 17.5\text{ A}$ ,  $T_{vj} = 175\text{ °C}$ ,  $V_{DD} = 800\text{ V}$



Typical switching times as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$

$t = f(R_{G,ext})$

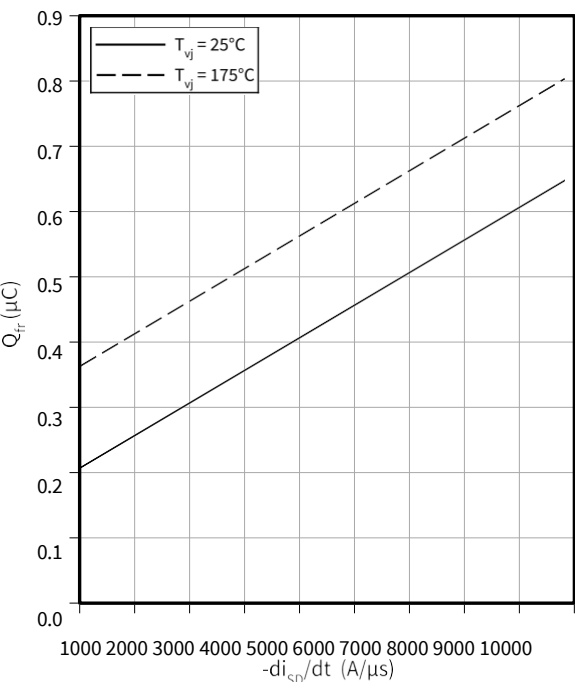
$I_D = 17.5\text{ A}$ ,  $T_{vj} = 175\text{ °C}$ ,  $V_{DD} = 800\text{ V}$ ,  $V_{GS} = 0/18\text{ V}$



Typical reverse recovery charge as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$

$Q_{fr} = f(-di_{SD}/dt)$

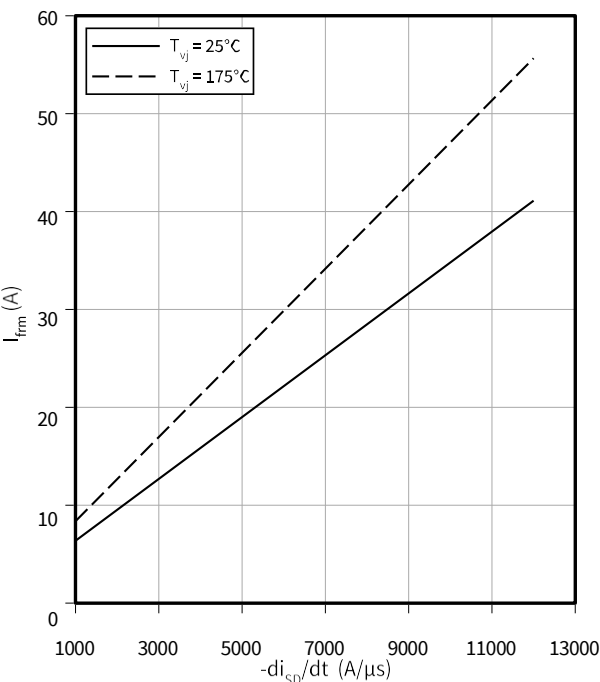
$V_{GS} = 0/18\text{ V}$ ,  $I_{SD} = 17.5\text{ A}$ ,  $V_{DD} = 800\text{ V}$



Typical reverse recovery current as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$

$I_{frm} = f(-di_{SD}/dt)$

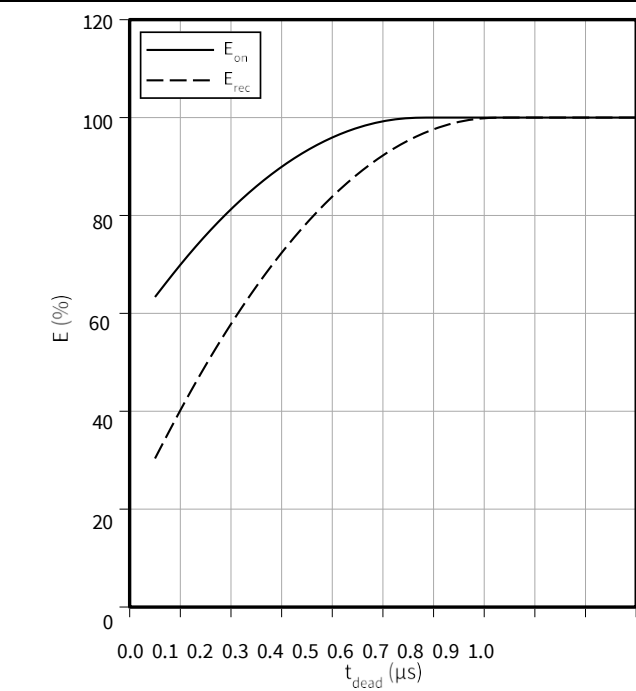
$V_{GS} = 0/18\text{ V}$ ,  $I_{SD} = 17.5\text{ A}$ ,  $V_{DD} = 800\text{ V}$



Typical switching energy as a function of dead time / blanking time, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = -5\text{ V}$

$E = f(t_{dead})$

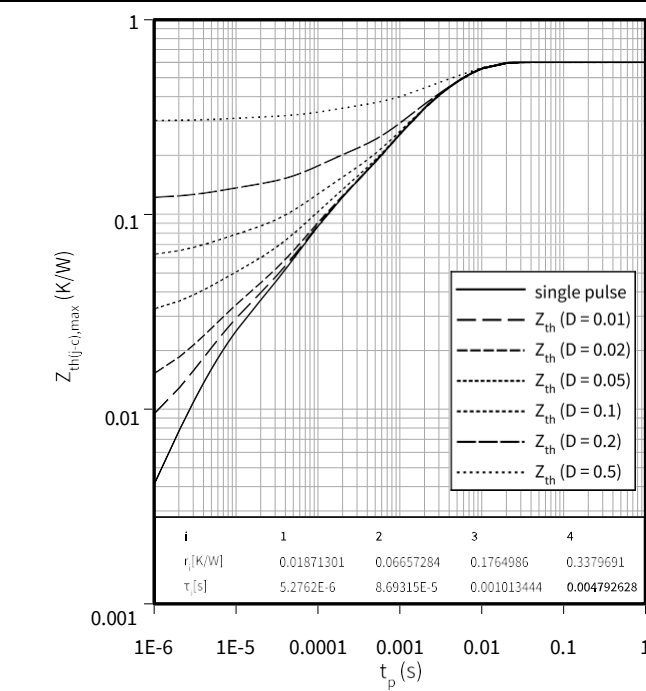
$V_{GS} = 0/18\text{ V}$ ,  $I_D = 17.5\text{ A}$ ,  $T_{vj} = 175\text{ °C}$ ,  $R_{G,ext} = 2.3\text{ }\Omega$   $V_{DD} = 800\text{ V}$



Max. transient thermal impedance (MOSFET/diode)

$Z_{th(j-c),max} = f(t_p)$

$D = t_p/T$



5 封装外形

5 封装外形

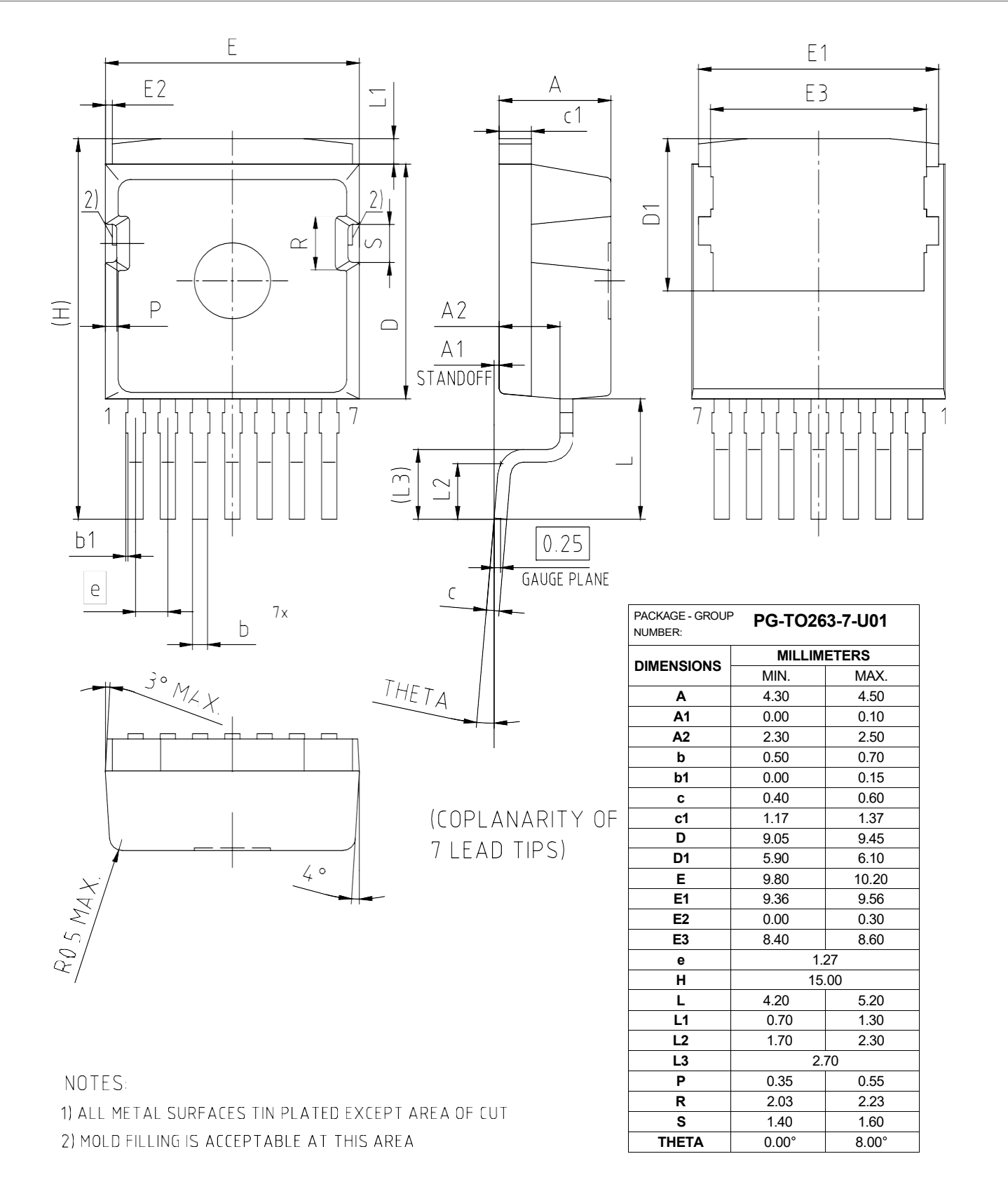


图 1

6 测试条件

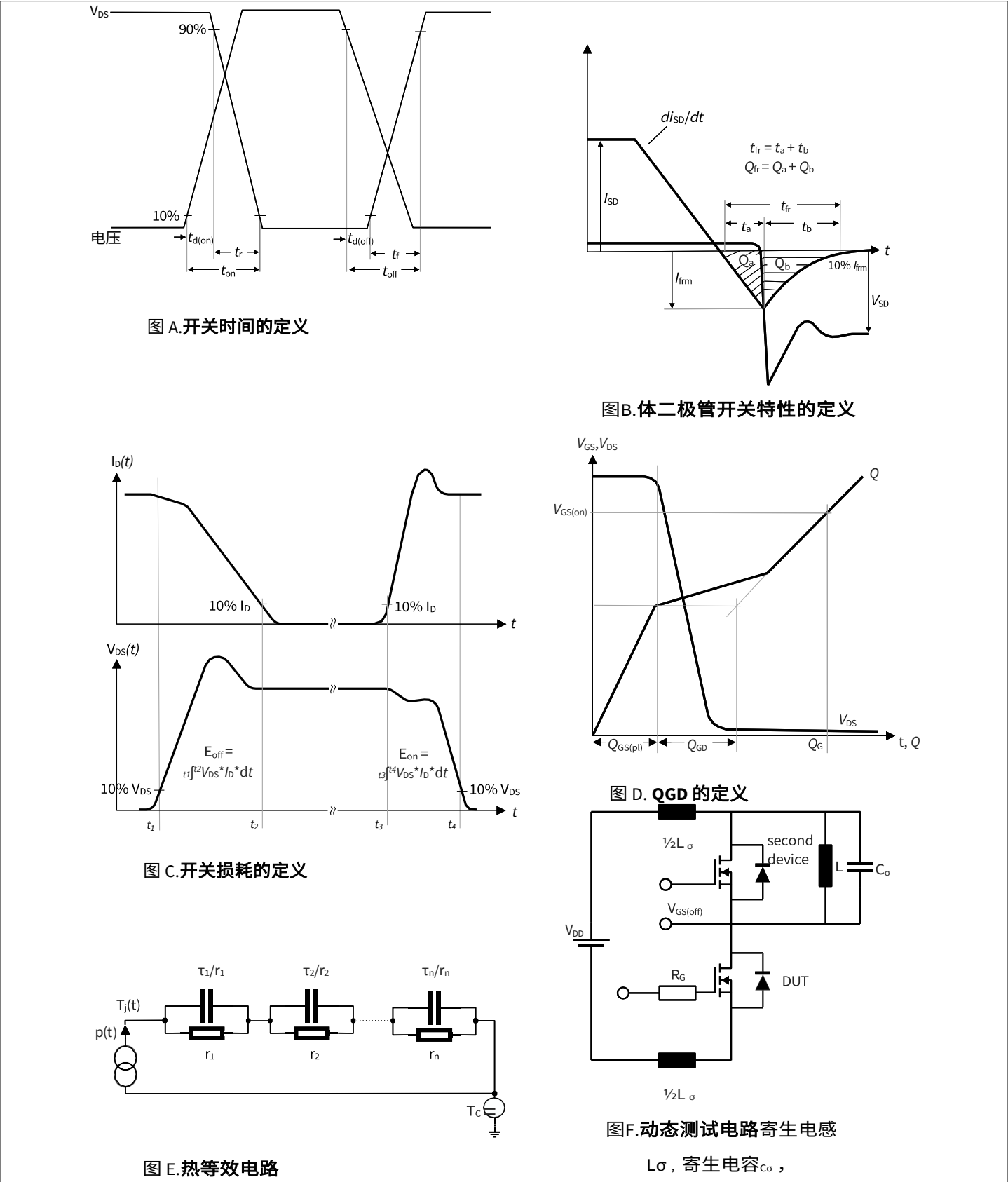


图 2

修订记录

修订记录

| Document revision | Date of release | Description of changes                                                                                                                                                                                                                                                                                                                                                              |
|-------------------|-----------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 0.10              | 2023-08-08      | Preliminary datasheet                                                                                                                                                                                                                                                                                                                                                               |
| 1.00              | 2023-10-05      | Final datasheet                                                                                                                                                                                                                                                                                                                                                                     |
| 1.10              | 2024-01-16      | Negative gate voltage values updated<br>Additional capacitance & charge values added<br>$E = f(t_{dead})$ graph y-axis correction to percentage values<br>Editorial changes                                                                                                                                                                                                         |
| 1.20              | 2024-07-02      | Updated „Potential applications“ Corrected package name<br>Corrected static and dynamic gate-source voltage<br>Corrected unit of L to $\mu H$ for “Avalanche energy, repetitive”<br>Corrected value of $g_{fs}$ in the Table 4<br>Corrected diagrams "Typical transfer characteristic" and "Max. transient thermal impedance (MOSFET/diode)"<br>Updated Figure D. Definition of QGD |
| 1.30              | 2024-11-08      | Corrected diagram $I_{frm} = f(-di_{sd}/dt)$ Editorial changes                                                                                                                                                                                                                                                                                                                      |



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